## Notice of References Cited Application/Control No. 10/005,473 Applicant(s)/Patent Under Reexamination KREANG-AREKUL ET AL. Examiner Barry Choobin Application/Control No. Applicant(s)/Patent Under Reexamination KREANG-AREKUL ET AL. Page 1 of 1

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-2005/0129299	06-2005	Kreang-Arekul et al.	382/132
	В	US-2004/0263790	12-2004	VanOverloop et al.	353/031
	С	US-2004/0008810	01-2004	Nelson et al.	378/19
	D	US-2003/0209672	11-2003	Nelson et al.	250/394
	Е	US-2003/0209662	11-2003	Nelson et al.	250/252.1
	F	US-2003/0206179	11-2003	Deering, Michael F.	345/589
	G	US-2003/0179923	09-2003	Xiong et al.	382/154
	Н	US-2003/0063383	04-2003	Costales, Bryan L.	359/464
	٠ ا	US-2003/0053136	03-2003	Chang, Ching-Wei	358/3.06 -
	J	US-2002/0114536	08-2002	Xiong et al.	382/284
	к	US-2002/0012004	01-2002	Deering, Michael F.	345/589
	L	US-2002/0008697	01-2002	Deering, Michael F.	345/418
	М	US-6,750,873	06-2004	Bernardini et al.	345/582

## **FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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## **NON-PATENT DOCUMENTS**

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